

Rohs

HFS9N50-VB Datasheet N-Channel 650V (D-S) Power MOSFET

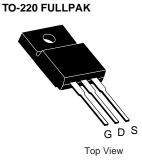
PRODUCT SUMMA	RY			
V_{DS} (V) at T_J max.	650			
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.65		
Q _g max. (nC)	43			
Q _{gs} (nC)	5			
Q _{gd} (nC)	22			
Configuration	Sing	le		

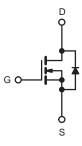
FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C :	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	650	- v	
Gate-Source Voltage			V _{GS}	± 30		
	V =======	T _C = 25 °C		12		
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	V _{GS} at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	I _D	9.4	А	
Pulsed Drain Current ^a			I _{DM}	45		
Linear Derating Factor				3.6	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	290	mJ	
Maximum Power Dissipation			PD	106 /34	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope $T_J = 125 \text{ °C}$		-1) (/-1+	15	V/ns		
Reverse Diode dV/dt ^d		dV/dt	4.1			
Soldering Recommendations (Peak Temperature) ^c	for	10 s		300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.5 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dI/dt = 100 A/µs, starting T_J = 25 °C.



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		MAX.			UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		60			0 0 00		
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.8				°C/W			
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u		se noted)			I	1	I		
PARAMETER	SYMBOL	TES	r condit	IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D =	250 µA	650	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.75	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	3	-	5	V	
Cata Sauraa Laakaaa	1	$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA		
Gate-Source Leakage	I _{GSS}			-	-	± 1	μA		
		V _{DS} =	= 650 V, V _G	_{iS} = 0 V	-	-	1		
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 520 V	$V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$		-	-	10	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$		I _D = 8 A	-	0.65	-	Ω	
Forward Transconductance	g fs	V _{DS}	= 30 V, I_D	= 8 A	-	16	-	S	
Dynamic					•				
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	1600	-		
Output Capacitance	C _{oss}		$V_{DS} = 100$	V,	-	300	-		
Reverse Transfer Capacitance	C _{rss}		f = 1 MH:	2	-	200	-	_	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V – 0)	′ to 520 V,	V – 0 V	-	63	-	pF	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	v _{DS} = 0 v	10 520 V,	v _{GS} = 0 v	-	213	-		
Total Gate Charge	Qg				-	43	96		
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	I _D = 8 /	A, V _{DS} = 520 V	-	5	-	nC	
Gate-Drain Charge	Q _{gd}				-	22	-		
Turn-On Delay Time	t _{d(on)}				-	13	25		
Rise Time	t _r	$\label{eq:VDD} \begin{array}{l} V_{DD}=520 \mbox{ V, } I_{D}=8 \mbox{ A,} \\ V_{GS}=10 \mbox{ V, } R_{g}=9.1 \ \Omega \end{array}$		-	11	35	ns		
Turn-Off Delay Time	t _{d(off)}			-	81	90			
Fall Time	t _f			-	25	40			
Gate Input Resistance	Rg	f = 1	MHz, ope	n drain	-	3.5	-	Ω	
Drain-Source Body Diode Characteristic	s	T							
Continuous Source-Drain Diode Current	I _S	MOSFET syml showing the	loc		-	-	15	•	
Pulsed Diode Forward Current	I _{SM}	p - n junction diode		40	A				
Diode Forward Voltage	V _{SD}	T _J = 25 °	C, I _S = 8 A	, V _{GS} = 0 V	-	-	1.5	V	
Reverse Recovery Time	t _{rr}				-	345	-	ns	
Reverse Recovery Charge	Q _{rr}	$T_J = 2$	5 °C, I _F =	_S = 8 A,	_	4.5	-	μC	
Reverse Recovery Current	I _{RRM}	ai/at = 1	00 A/μs, \	r _R = 400 V	-	35	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

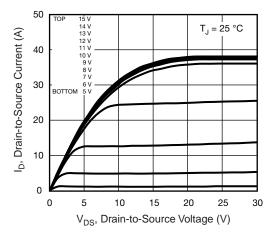


Fig. 1 - Typical Output Characteristics

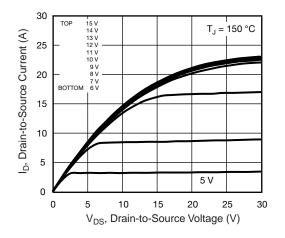


Fig. 2 - Typical Output Characteristics

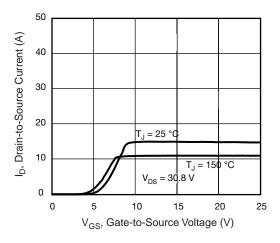


Fig. 3 - Typical Transfer Characteristics

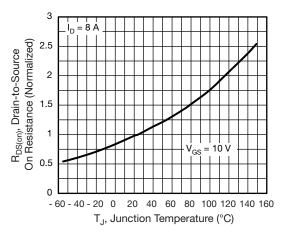


Fig. 4 - Normalized On-Resistance vs. Temperature

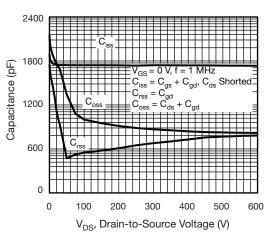


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

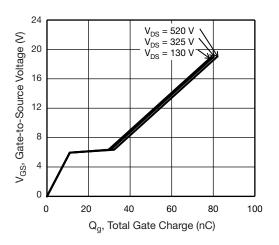


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

HFS9N50-VB



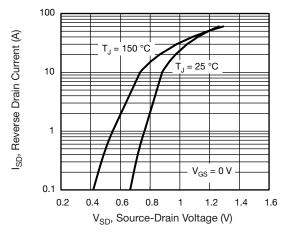
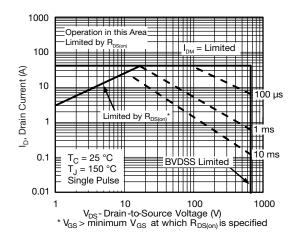


Fig. 7 - Typical Source-Drain Diode Forward Voltage





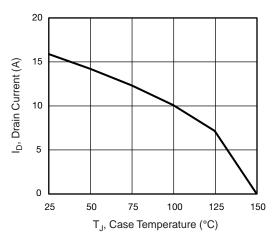


Fig. 9 - Maximum Drain Current vs. Case Temperature

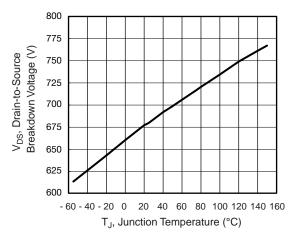


Fig. 10 - Temperature vs. Drain-to-Source Voltage

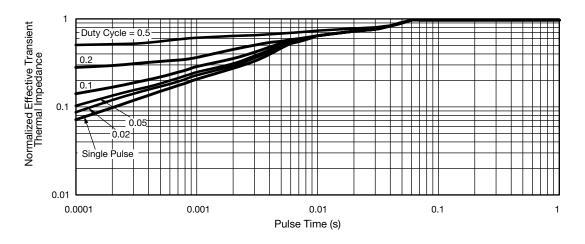


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



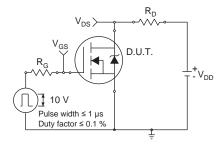


Fig. 12 - Switching Time Test Circuit

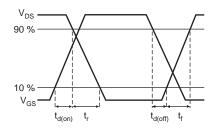


Fig. 13 - Switching Time Waveforms

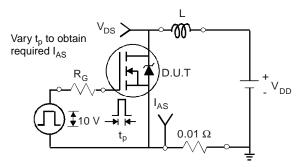


Fig. 14 - Unclamped Inductive Test Circuit

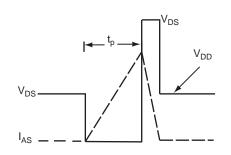


Fig. 15 - Unclamped Inductive Waveforms

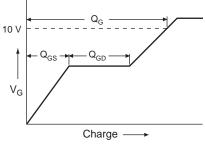


Fig. 16 - Basic Gate Charge Waveform

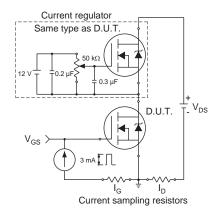
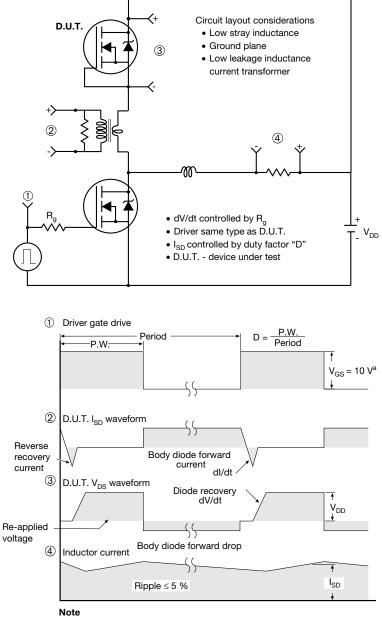


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

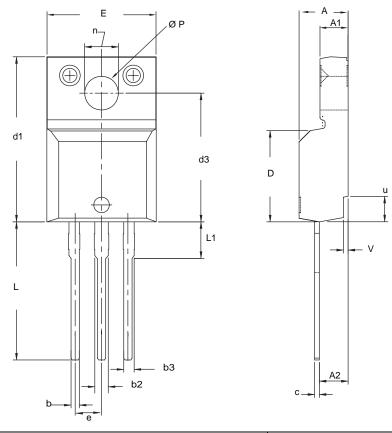


a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



DIM.	MILLI	METERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
C	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500 0.094		0.098	
V	0.400	0.500	0.016	0.020	

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.



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